

# μPD166025T1J

# INTELLIGENT POWER DEVICE

R07DS1112EJ0200 Rev.2.00 May 22, 2015

#### 1. Overview

#### 1.1 Description

#### Family:

μPD166025T1J is part of 2nd Generation Intelligent Power Devices (IPD). This is N-channel high-side switch with charge pump, voltage controlled input, diagnostic feedback with proportional load current sense and embedded protection function. Family includes up to 14 devices depending on on-state resistance, package and channel number combination.

#### Scalability:

Variety of on-state resistance combined with standardized package on pin-out give user high flexibility for unit design depending on target load.

#### Robustness:

Because of advanced protection method, 2nd Generation Intelligent Power Devices achieve high robustness against long term and repetitive short circuit condition.

#### 1.2 Features

- Built-in charge pump
- 3.3V compatible logic interface
- Low standby current
- Short circuit protection
  - Shutdown by over current detection
  - Power limitation protection by over load detection (Power limitation: current limitation with delta Tch control)
  - Absolute Tch over temperature protection
- Built-in diagnostic function
  - Proportional load current sensing
  - Defined fault signal in case of abnormal load condition
- Loss of ground protection
- Under voltage lock out
- Active clamp operation at inductive load switch off
- Cross current protection in case of H-bridge high side usage
- AEC Qualified
- RoHS compliant

#### 1.3 Application

- Light bulb switching from 40W to 55W
- Switching of all types of 14V DC grounded loads, such as LED, inductor, resistor and capacitor
- Power supply switch, fail-safe switch of 14V DC grounded system

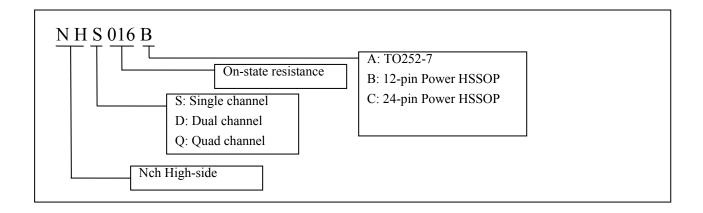
Note: The information contained in this document is the one that was obtained when the document was issued, and may be subject to change.

# 2. Ordering Information

Part No.	Nick name	Lead plating	Packing	Package
UPD166025T1J-E1-AY	NHS016B	Pure Matte Sn	Tape 1500 p/reel	12-pin Power HSSOP
UPD166025T1J-E2-AY	NHS016B	Pure Matte Sn	Tape 1500 p/reel	12-pin Power HSSOP

Note: MSL: 1, profile acc. J-STD-20C

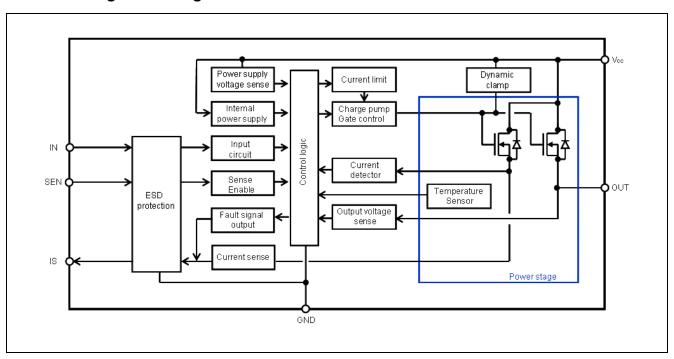
#### 2.1 Nick name



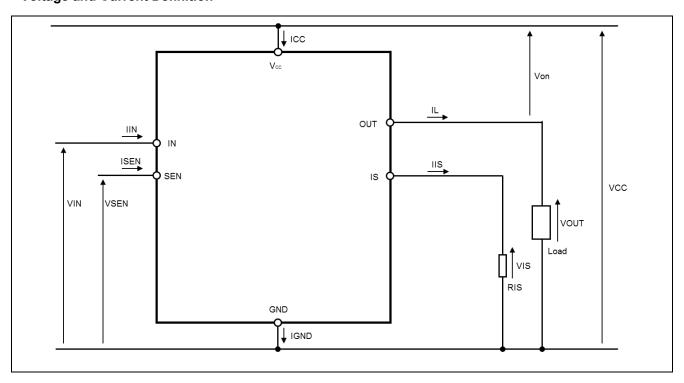
# 3. Specification

# 3.1 Block Diagram

# 3.1.1 Nch High-side Single Device



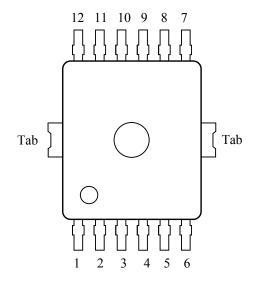
#### **Voltage and Current Definition**



# 3.2 Pin Configuration

# 3.2.1 12-pin Power HSSOP Pin Configuration

Pin No.	Terminal Name
1	GND
2	N.C.
3	IS
4	N.C.
5	IN
6	VCC
7	SEN
8	OUT
9	OUT
10	OUT
11	OUT
12	VCC
Tab	VCC



### Pin function

Terminal Name	Pin function	Recommended connection
GND	Ground connection	Connected to GND through a 100 Ohm resistor
		or a diode for reverse current protection
		Refer chapter 6.
IN	Input signal	Connected to MCU port through 2k-50K serial
		resistor
IS	Current sense and Diagnosis output signal	Connected to GND through a 0.67K-5K resistor
SEN	Sense enable input	Connected to MCU port through 2k-50K serial
		resistor
OUT	Protected high-side power output	Connected to load with small 50-100nf capacitor
		in parallel
VCC	Positive power supply for logic supply as well as	Connected to battery voltage with small 100nf
	output power supply	capacitor in parallel
N.C.	Non connection	Left open

# 3.3 Absolute Maximum Ratings

Ta=25degreeC, unless other specified

Parameter	Symbol	Rating	Unit	Test Condition	n	
Vcc Voltage	$V_{CC}$	28	V			
Vcc Voltage at reverse battery condition	-V <sub>CC</sub>	-16	V	RL=20hm, t<2min, RIN=2kohm, RSEN=2kohm, RIS=1kohm, RGND=1000hm		
GND Reverse current at reverse battery condition	I <sub>GND(Rev)</sub>	200	mA	RL=2ohm, t<	2min	
Vcc voltage under Load Dump condition	V <sub>load dump</sub>	42	V		=2ohm, RIS=1kohm, RIN=2kohm, n , RGND=100ohm, td=400ms,	
Load Current	IL	Self limited	Α			
Total power dissipation for whole device (DC)	P <sub>D</sub>	1.85	W	with	C, mmx50mmx1.5mm epoxy PCB FR4 m copper area	
Voltage at IN pin	V <sub>IN</sub>	-2 ~ 16	V	DC RIN=2kohm		
		-16		RIN=2kohm, I	ttery condition, t<2min, RSEN=2kohm	
IN pin current	I <sub>IN</sub>	10	mA	DC		
Voltage at IS pin	VIS	VCC	V	DC RIS=1kohm		
		-16	V	RL=2ohm, RI		
IS Reverse current at reverse battery condition	IIS(Rev)	-30	mA	RL=2ohm	ttery condition, t<2min,	
Voltage at SEN pin	V <sub>SEN</sub>	-2 ~ 16	V	DC RSEN=2kohn	n	
		-16		At reverse battery condition, t<2min RIN=2kohm, RSEN=2kohm		
SEN pin current	I <sub>SEN</sub>	10	mA	DC		
Channel Temperature	Tch	-40 to +150	degreeC			
Storage Temperature	Tstg	-55 to +150	degreeC			
ESD susceptibility	Vesd	2000	V	HBM	AEC-Q100-002 std. All pin R=1.5kohm, C=100pF	
		4000			IEC61000-4-2 std. R=330ohm, C=150pF, 100nF at VCC and OUT	
		200	V	MM	AEC-Q100-003 std. R=0ohm, C=200pF	
Inductive load switch-off energy dissipation single pulse	EAS	100	mJ	VCC=13.5V,	Tch,start<150degreeC, RL=2ohm	
Inductive load switch-off energy dissipation repetitive pulse	EAR	61	mJ	VCC=13.5V,	Tch,start=85degreeC, RL=2ohm	

# 3.4 Thermal Characteristics

Parameter	Symbol	Min	Тур	Max	Unit	Test Condition
Thermal characteristics	Rth(ch-a)		35		degree C/W	According to JEDEC JESD51-2, -5, -7 on FR4 2s2p board
	Rth(ch-c)		1.4		degree C/W	

### 3.5 Electrical Characteristics

#### **Operation function**

Tch=-40 to 150degreeC, Vcc=7 to 18V, unless otherwise specified

Parameter	Symbol	Min	Тур	Max	Unit	Test Condition	
Operating Voltage	V <sub>CC</sub>	4.5		28	V	V <sub>IN</sub> =4.5V	
						RL=2ohm	
Operating current	I <sub>GND</sub>		2.2	4	mA	VIN=4.5V	
Output Leakage current	I <sub>L(off)</sub>			0.5	μΑ	Tch=25°C	VCC=13.5V,
	, ,						VIN=0V,
							VSEN=0V,
				3		Tch=-40~125°C	VIS=0V,
							VOUT=0V,
							VGND=0V
Standby current	I <sub>CC(off)</sub>			0.5	μΑ	Tch=25°C	VCC=13.5V,
							VIN=0V,
							VSEN=0V,
				1.5		Tch=-40~85°C	VIS=0V,
							VOUT=0V,
							VGND=0V
On-state resistance	Ron		16		mohm	Tch=25°C, IL=6.8A	1
				32		Tch=150°C, IL=6.8A	
Low level IN pin voltage	$V_{IL}$			8.0	V		
High level IN pin voltage	$V_{IH}$	2.5			V		
Low level IN pin current	I <sub>IL</sub>	2		25	μΑ	VIN=0.8V	
High level IN pin current	I <sub>IH</sub>	2		25	μΑ	VIN=2.5V	
Clamping IN pin voltage 1)	$V_{ZIN}$	5	6		V		
Low level SEN pin voltage	$V_{SENL}$			8.0	V		
High level SEN pin voltage	$V_{SENH}$	2.5			V		
Low level SEN pin current	I <sub>SENL</sub>	2		25	μΑ	VSEN=0.8V	
High level SEN pin current	I <sub>SENH</sub>	2		25	μΑ	VSEN=2.5V	
Clamping SEN pin voltage <sup>1)</sup>	$V_{ZSEN}$	5	6		V		
Under voltage shutdown	V <sub>CC(Uv)</sub>			4.5	V		
Under voltage restart	V <sub>CC(Cpr)</sub>			5.0	V		
Turn on time	ton			200	μs	VCC=13.5V, RL=2ohm	
Turn on delay time	td(on)			100	μs		
Turn off time	toff			200	μs		
Turn off delay time	td(off)			150	μs		
Slew rate on	dV/dton			1.0	V/µs		
Slew rate off	-dV/dtoff			1.0	V/µs		
Switching drift <sup>1)</sup>	ton-toff	-50		+50	μs	Vcc = 9 to 18V drift from Vc	
						Tch=-40 to 150degreeC drift	ft from
						Tch=25degreeC	
						ton; Vout=Vcc-1.5V after in	
Turn on energy loss 1)	Eon		1.2	2.4	mJ	VCC=13.5V,Tch=25°C, RL=	=2ohm
Turn off energy loss 1)	Eoff		1.2	2.4	mJ		
Driving capability 1)	Dr(capa)	125			mohm	Tch=25°C, VCC=8~16V	
		160			]	Tch=105°C, VCC=8~16V	

Remark) All voltages refer to ground pin of the device

1) not subjected production test, guaranteed by design

#### **Protection function**

Tch=-40 to 150degreeC, Vcc=7 to 18V, unless otherwise specified

Parameter	Symbol	Min	Тур	Max	Unit	Test Condition
Over current detection current	IL(SC)	68	114		Α	VCC=13.5V, Von=5V, Tch=25°C
Current limitation under power limitation toggling	IL(CL)		48		Α	VCC=13.5V
Current limitation under absolute thermal toggling	IL(TT)		19		Α	VCC=13.5V
Current limitation trigger threshold during turn-on	Von(CL1)		2.0		V	VCC=13.5V
Current limitation trigger threshold during on-state	Von(CL2)		0.35		V	VCC=13.5V
Current limitation trigger time after input signal positive slope	td(CL)		500		μs	VCC=13.5V
Absolute thermal shutdown temperature	aTth	150			°C	
Thermal hysteresis for absolute thermal toggling	aTth,hys		20		°C	
Power limitation thermal shutdown temperature	dTth		50		°C	
Power limitation restart temperature	dTth,rest art		25		°C	
Output clamp at inductive load switch off	Von,clam p	30		40	V	VCC=13.5V, IL=40mA, Tch=25°C
Output current while GND disconnection	IL(GND)			1	mA	IIN=0A, ISEN=0A, IGND=0A, IIS=0A
Output voltage drop at	Vds(rev)			0.9	V	Tch=25°C VCC=-13.5V,
reverse battery condition				0.7		Tch=150°C RL=2ohm

# **Diagnosis function**

Tch=-40 to 150degreeC, Vcc=7 to 18V, VIN=4.5V, VSEN=4.5V, unless otherwise specified

Parameter	Symbol	Min	Тур	Max	Unit	Test Condition
Current sense ratio	KILIS	4640	5800	6960		IL=6.0A
		4060	5800	7540		IL=1.2A
Current sense drift depend	dKILIS	-5		9	%	IL=1.8A~3.8A,
on temperature						Calibration point:
						IL=4.0A, VCC=13.5V, Tch=25°C
		-12		12	%	VCC=13.5V, Tch,start=25°C,
						RL=2ohm
Sense current offset	lis,offset			2	μΑ	IL<10mA
current						
Sense current leakage	lis,dis			1	μA	VIN=0V, VSEN=0V
current						
Sense current under fault	lis,fault	3		9.5	mA	VCC=13.5V, RIS=0.67kohm
condition		3.5		9		VCC=13.5V, RIS=1kohm
		3.5		5.5		VCC=13.5V, RIS=2kohm
Minimum output current for	IL(CSE)	10		100	mA	IIS>5µA
current sense output						
Open load detection	VOUT(OL)	2.0		5.0	V	VIN=0V, Tch=-40~105°C
threshold at off-state						
OUT terminal current at	IOUT(OL)	-1.0			μA	VIN =0V
Open load condition						
Open load detection delay	tdop		300		μs	VIN=4.5V to 0V, VOUT>VOUT(OL)
after input negative slope						

### **Diagnosis function**

Tch=-40 to 150degreeC, Vcc=7 to 18V, VIN=4.5V, VSEN=4.5V, unless otherwise specified

Parameter	Symbol	Min	Тур	Max	Unit	Test Condition
Sense current settling time after input signal positive slope	tsis(on)			250	μs	VCC=13.5V, VIN=0V to 4.5V, IL/IIS=KILIS, RL=2ohm
Sense current settling time after input signal negative slope	tsis(off)			10	μs	VIN=4.5V to 0V
Sense current settling time after sense enable during on-state <sup>1)</sup>	tssen(on)			20	μs	VSEN=0V to 4.5V, RL=2ohm
Sense current settling time after sense disable during on-state 1)	tssen(off)			20	μs	VSEN=4.5V to 0V, RL=2ohm
Sense current settling time during on-state 1)	tsis(LC)			20	μs	RL=2ohm to 1ohm
Fault signal delay after over current detection 1)	tdsc(fault)			10	μs	VIN=0V to 4.5V, IL=IL(SC)
Fault signal delay after power limitation valid 1)	tdpl(fault)			10	μs	Von>Von(CL1)
Fault signal delay after power limitation invalid 1)	tdpl(off)			30	μs	Von <von(cl1)< td=""></von(cl1)<>
Fault signal delay after absolute thermal shutdown	tdot(fault)			10	μs	IIS→IIS,fault
Fault signal delay after open load detection at off-state 1)	tdop(fault)			10	μs	VIN=0V, VOUT>VOUT(OL)
Fault signal delay after input negative slope 1)	tdoff(fault)			10	μs	VIN=4.5V to 0V

<sup>1)</sup> not subjected production test, guaranteed by design

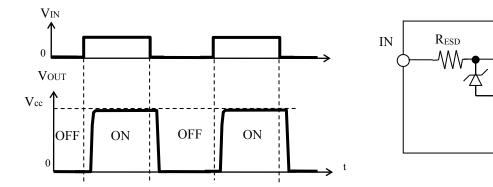
Internal ground

GND

# 3.6 Feature Description

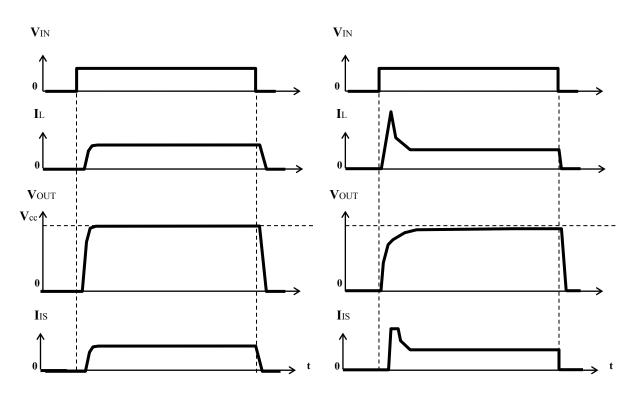
# 3.6.1 Driving Circuit

The high-side output is turned on, if the input pin is over VIH. The high-side output is turned off, if the input pin is open or the input pin is below VIL. Threshold is designed between VIH min and VIL max with hysteresis. IN terminal is pulled down with constant current source.

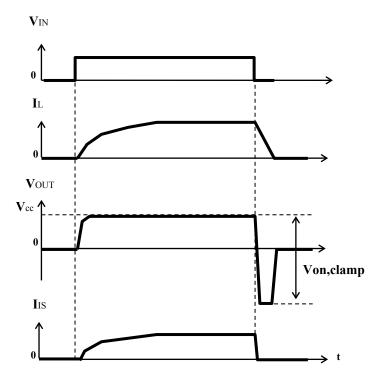


#### Switching a resistive load

#### **Switching lamps**



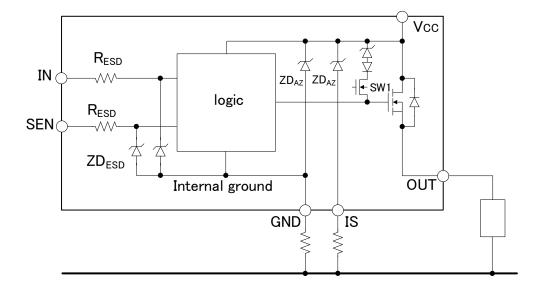
#### Switching an inductive load



The dynamic clamp circuit works only when the inductive load is switched off. When the inductive load is switched off, the voltage of OUT falls below 0V. The gate voltage of SW1 is then nearly equal to GND. Next, the voltage at the source of SW1 (= gate of output MOS) falls below the GND voltage.

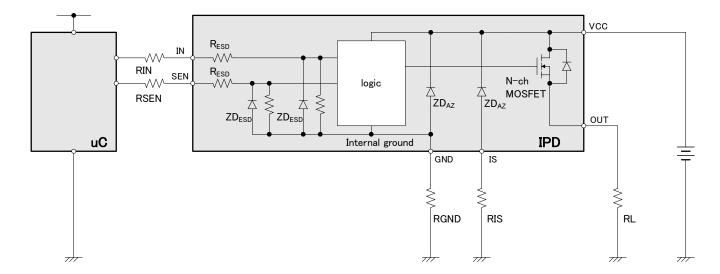
SW1 is turned on, and the clamp diode is connected to the gate of the output MOS, activating the dynamic clamp circuit.

When the over-voltage is applied to VCC, the gate voltage and source voltage of SW1 are both nearly equal to GND. SW1 is not turned on, the clamp diode is not connected to the gate of the output MOS, and the dynamic clamp circuit is not activated.



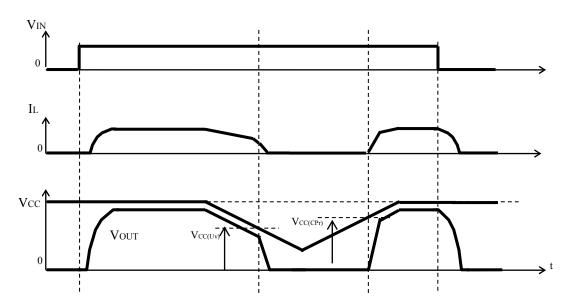
### 3.6.2 Device behavior at over voltage condition

In case of supply voltage greater than Vload dump, logic part is clamped by  $ZD_{AZ}$  (35V min). And current through of logic part is limited by external ground resistor. In addition, the power transistor switches off in order to protect the load from over voltage. Permanent supply voltage than  $V_{load}$  dump must not be applied to VCC.



#### 3.6.3 Device behavior at low voltage condition

If the voltage supply  $(V_{CC})$  goes down under  $V_{CC}(Uv)$ , the device outputs shuts down. If voltage supply  $(V_{CC})$  increase over  $V_{CC}(Cpr)$ , the device outputs turns back on automatically. The device keeps off state after under voltage shutdown. The IS output is cleared during off-state.



#### 3.6.4 Loss of Ground protection

In case of complete loss of the device ground connection, but connected load ground, the device securely changes to off if VIN was initially greater than VIH state or keeps off state if VIN was initially lower than VIL state.

In case of device loss of ground, IN and SEN terminal will/could/ might be at VCC voltage.

#### 3.6.5 Short circuit protection

### Turn-on in an over load condition including short circuit condition

The device shuts down automatically when condition (a) is detected. The sense pin output Iis,fault. Shutdown is latched until the next reset via input pin. The device shuts down automatically when condition (b) is detected. The device restarts automatically in power limitation mode. The device shuts down automatically when condition (c) is detected and restarts automatically in absolute thermal toggling mode. The device starts current limitation when (d) is detected. The sense pin output Iis,fault during power limitation mode or thermal toggling mode.

- (a) IL > IL(SC)
- (b) deltaTch > dTth
- (c) Tch > aTth
- (d) Von > Von(CL1) after td(CL)

### Over load condition including short circuit condition during on-state

The device runs automatically into power limitation mode when condition (a) is detected once after Von < Von(CL2). The device shuts down automatically when condition (b) is detected. The device restarts automatically in power limitation mode. The device shuts down automatically when condition (c) is detected and restarts automatically in absolute thermal toggling mode. The sense pin output Iis, fault during power limitation mode or thermal toggling mode.

- (a) Von > Von(CL2)
- (b) deltaTch > dTth
- (c) Tch > aTth

#### Power limitation control

Current limitation control with IL(CL) when auto restart from deltaTch protection.

During the current limitation operation and Von>Von(CL1), the sense pin outputs Iis,fault. Even auto restart from delta Tch protection, if Von<Von(CL1) depends on short circuit impedance condition, the device does not operate as current limitation with IL(CL). In this case, the sense pin output sense current at on-state, Iis,fault at off-state during toggling operation with power limitation mode.

#### Absolute thermal toggling

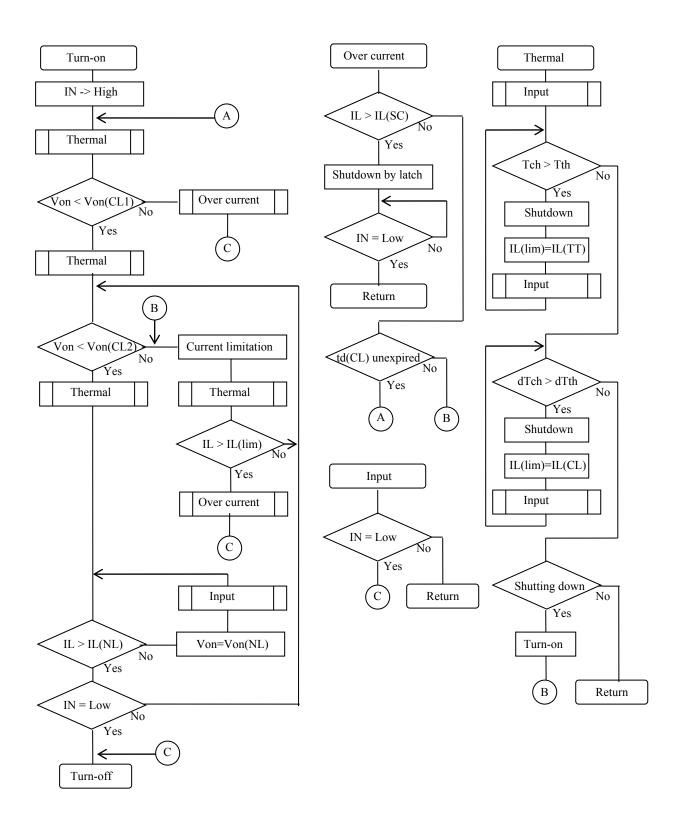
Current limitation control with IL(TT) when auto restart from absolute Tch protection.

During the current limitation operation and Von>Von(CL1), the sense pin outputs Iis, fault. Even auto restart from absolute Tch protection, if Von<Von(CL1) depends on short circuit impedance condition, the device does not operate as current limitation with IL(TT). In this case, the sense pin output sense current at on-state, Iis, fault at off-state during toggling operation with thermal toggling mode.

#### delta Tch

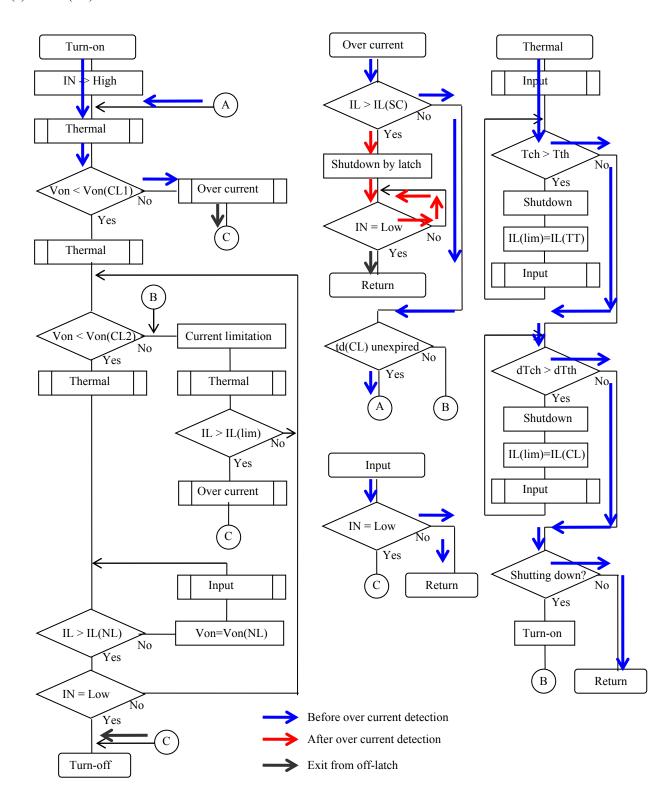
Junction temperature differences between thermal sensor of power area and thermal sensor of control area.

# State transition diagram



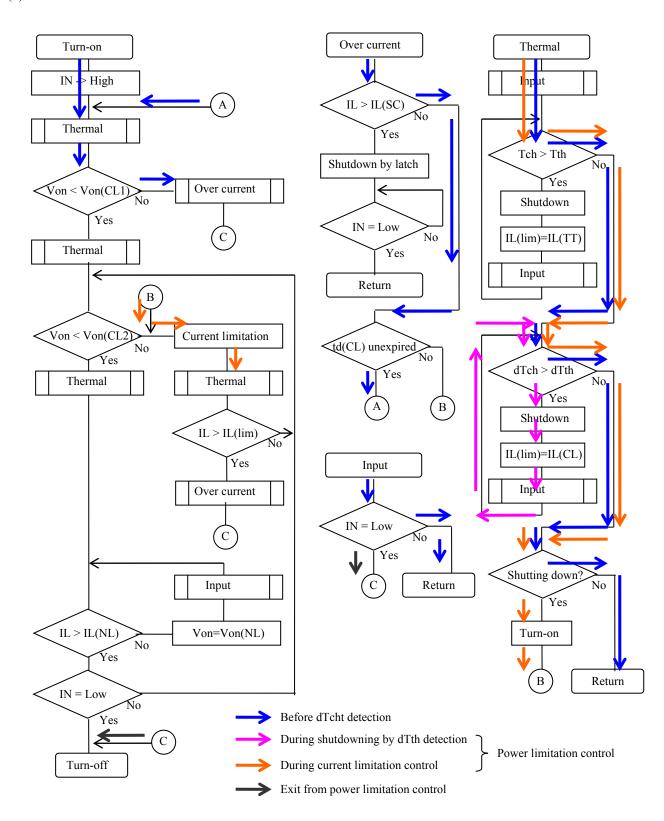
#### Turn-on in an over load condition including short circuit condition

(a) IL > IL(SC)



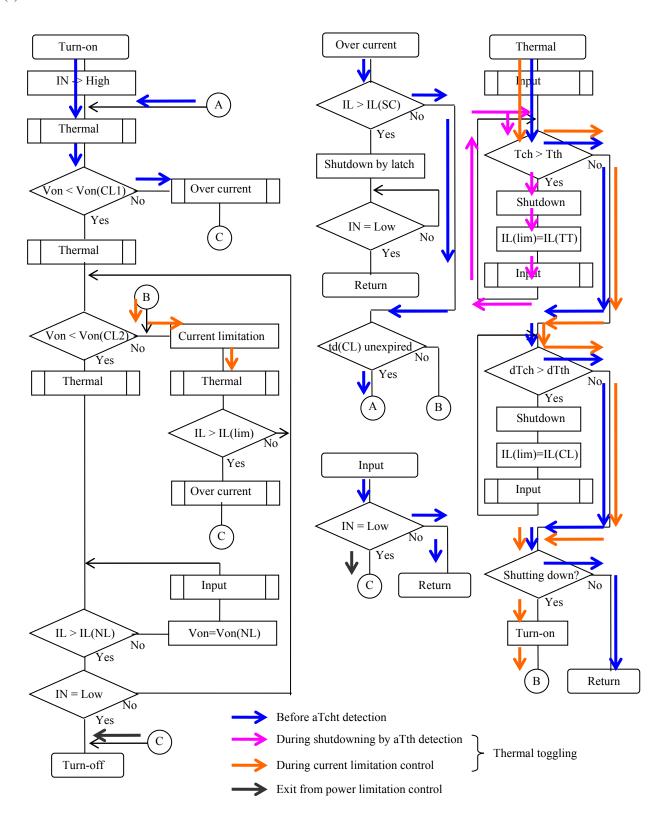
#### Turn-on in an over load condition including short circuit condition

(b) deltaTch > dTth



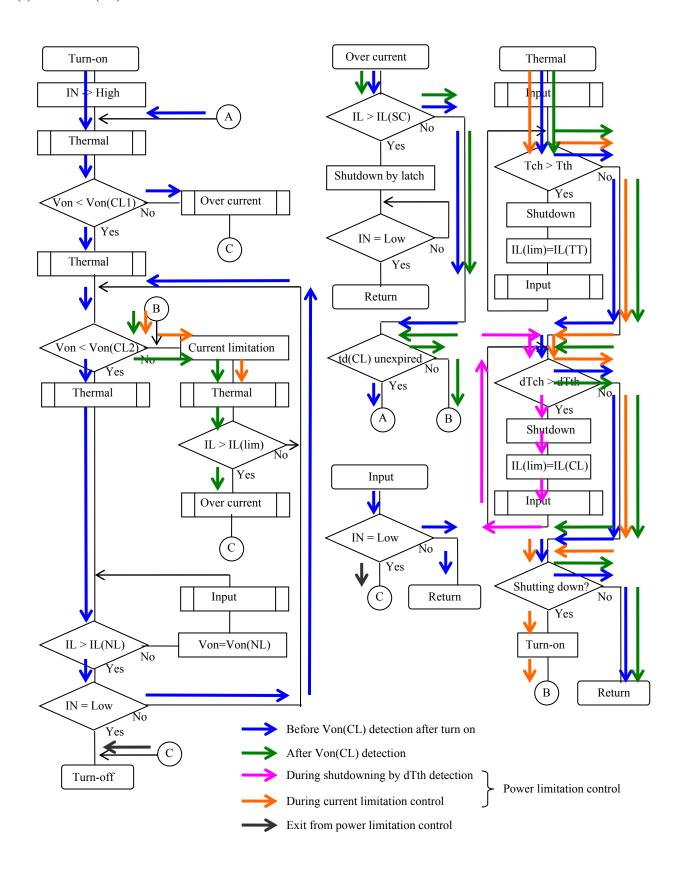
#### Turn-on in an over load condition including short circuit condition

(c) Tch > aTth



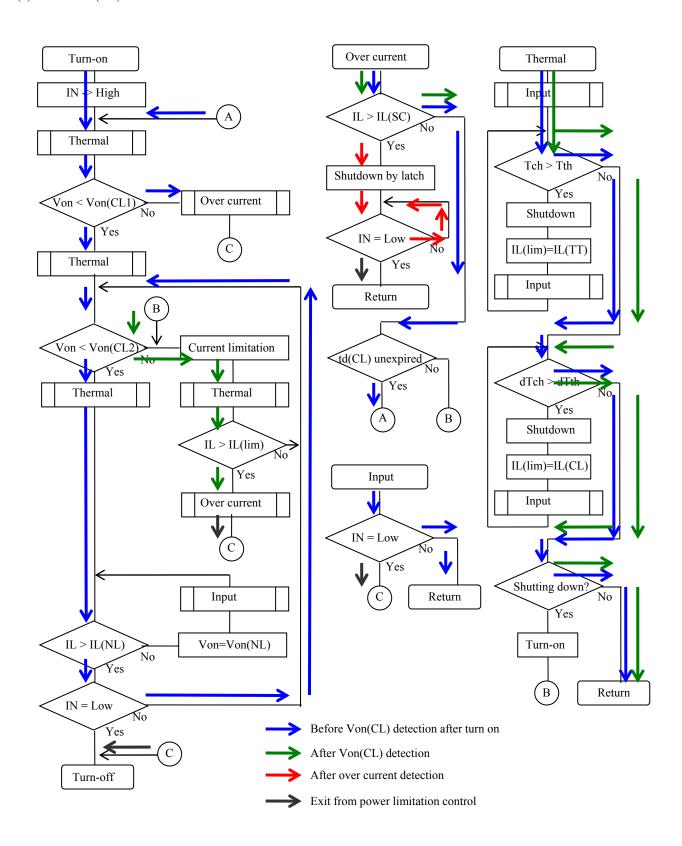
#### An over load condition which is include a short circuit condition during on-state

(a) Von > Von(CL) with weak short condition



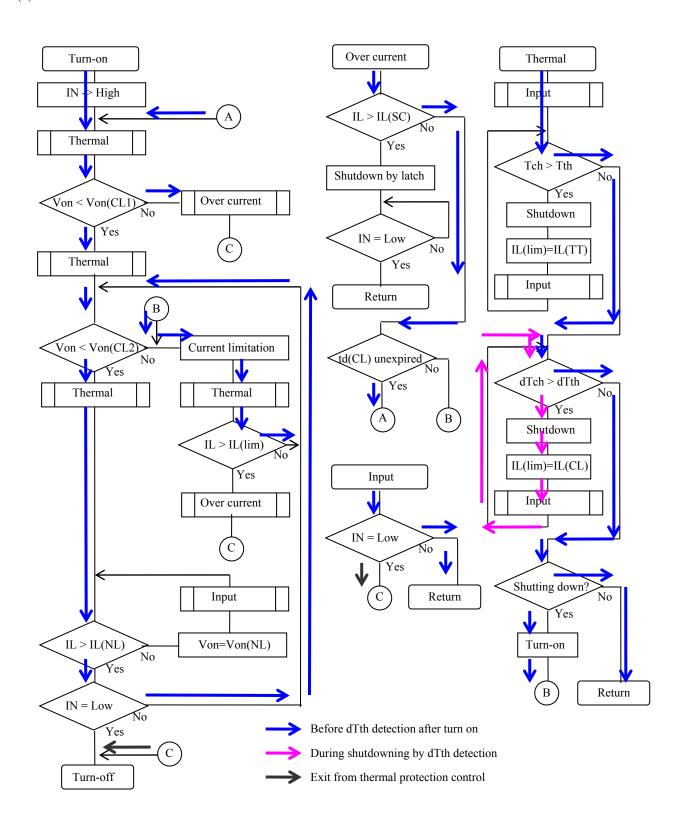
#### An over load condition including short circuit condition during on-state

(a) Von > Von(CL) with dead condition



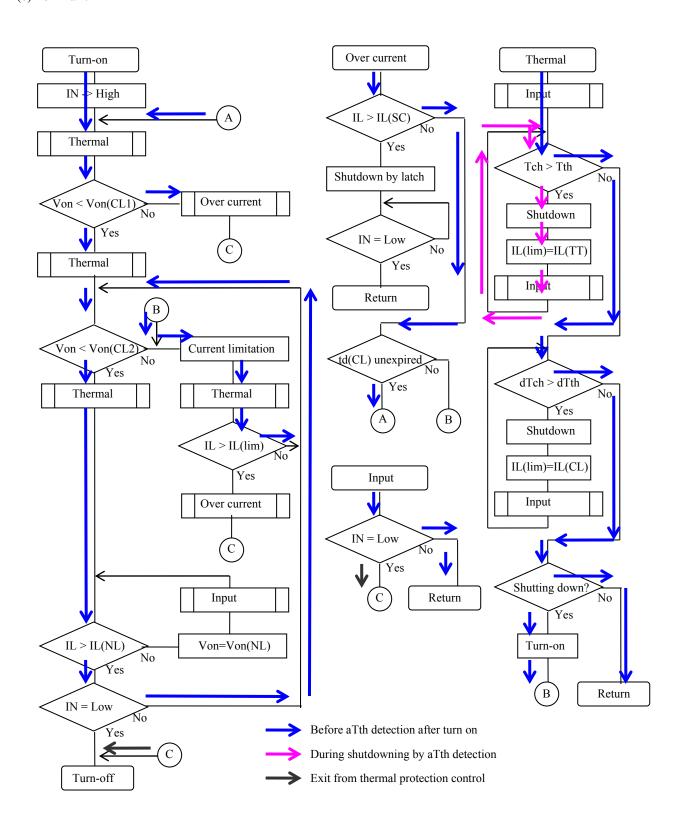
#### An over load condition including short circuit condition during on-state

(b) deltaTch > dTth



#### An over load condition including short circuit condition during on-state

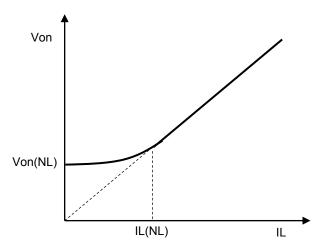
(c) Tch > aTth



#### 3.6.6 Device behavior at small load current conduction

The device has a function which controls Ron in order to improve KILIS accuracy at small load current conduction.

Von (VCC-OUT) is proportionate to IL under normal conditions. Under IL<IL(NL) condition, Ron is controlled to increase to be Von=Von(NL)=30mV(typ).



# 3.6.7 Diagnostic signal

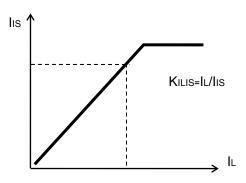
#### Truth table

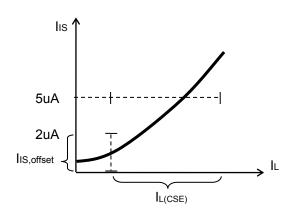
	SEN	Input	Output	Diagnostic output <sup>2)</sup>
Normal Operation	Н	Н	VCC	IIS = IL/KILIS
Normal Operation		L L <sup>1)</sup> < 1uA (Iis,dis)		< 1uA (Iis,dis)
Shutdown by over		Н	L 1)	Iis,fault <sup>3)</sup>
current detection		L	L 1)	< 1uA (Iis,dis)
			VOUT 6)	IIS = IL/KILIS in case of Von <von(cl1)< td=""></von(cl1)<>
Power limitation		Н	VO01	lis,fault 4) in case of Von>Von(CL1)
1 ower mintation			L 1)	Iis,fault 4)
		L	L 1)	< 1uA (Iis,dis)
		Н	VOUT 6)	IIS = IL/KILIS in case of Von <von(cl1)< td=""></von(cl1)<>
Thermal toggling				lis,fault 5) in case of Von>Von(CL1)
Thermal togginig			L1)	lis, fault <sup>5)</sup>
		L	L 1)	< 1uA (Iis,dis)
Short circuit to VCC		Н	VCC	< 2uA (Iis,offset)
Short encurt to VCC		L	VOUT 7)	Iis,fault in case of VOUT>VOUT(OL)
Open Load		Н	VCC	< 2uA (Iis,offset)
Open Load		L	VOUT 7)	Iis,fault in case of VOUT>VOUT(OL)
X 8)	L	X 8)	X 8)	< luA (Iis,dis)

- 1) In case of OUT terminal is connected to GND via load.
- 2) In case of IS terminal is connected to GND via resister.
- 3) IS terminal keeps Iis, fault as long as input signal activate after the over current detection.
- 4) IS terminal keeps Iis,fault during power limitation if Von>Von(CL1).
- 5) IS terminal keeps Iis, fault during thermal toggling if Von>Von(CL1)..
- 6) VOUT depends on the short circuit condition
- 7) VOUT depends on the ratio of VCC-OUT-GND resistive component.
- 8) Don't care

#### **Current sense output**

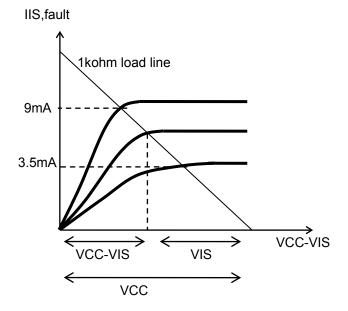
The device output analog feedback current proportional to output current from IS pin. In the case of much higher current than nominal load current, current sense output is saturated. In the case of much lower current than nominal load current, current sense output is above 5uA if output current is above IL(CSE) max, current sense output is below 2uA, IIS,offset max, if output current is below IL(CSE) min.

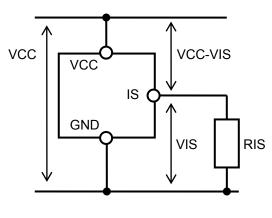




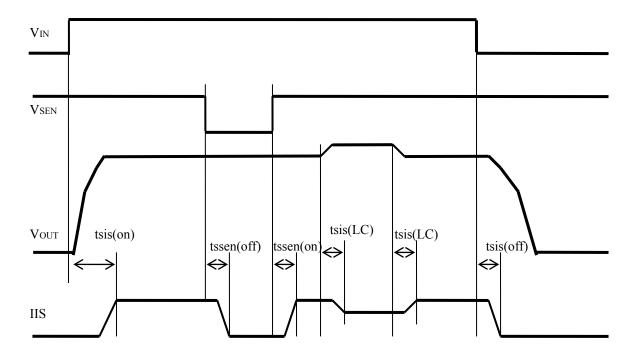
#### Sense current under fault condition

The device output IIS,fault, constant current, from IS pin under fault condition such as after over current detection, during power limitation and during thermal toggling. IIS,fault is specified with RIS=1kohm condition. IIS,fault is attenuated depends on VCC-VIS voltage. Operation point as IIS,fault output is also depends on RIS condition. For example, In the case of RIS=1kohm, IIS,fault could be 3.5mA to 9mA, VCC-VIS could be 4.5V to 10V, VIS could be 9V to 3.5V if VCC=13.5V. In the case of RIS is higher than 1kohm, Operation point as IIS,fault is lower than specified value but VIS should be higher than RIS=1kohm condition.

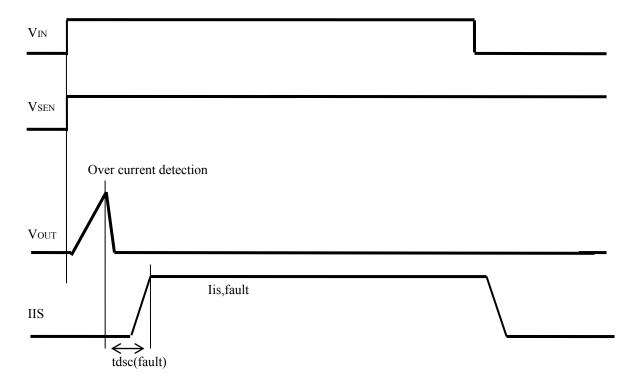




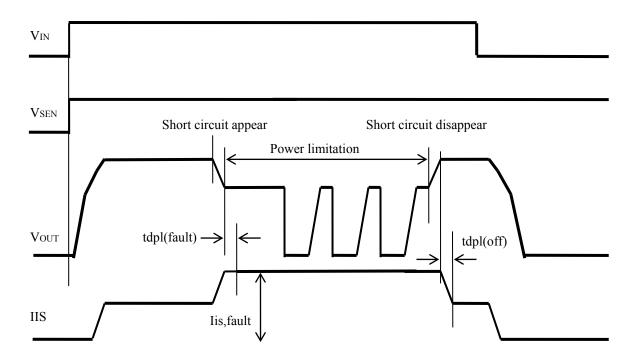
#### Sense current settling time



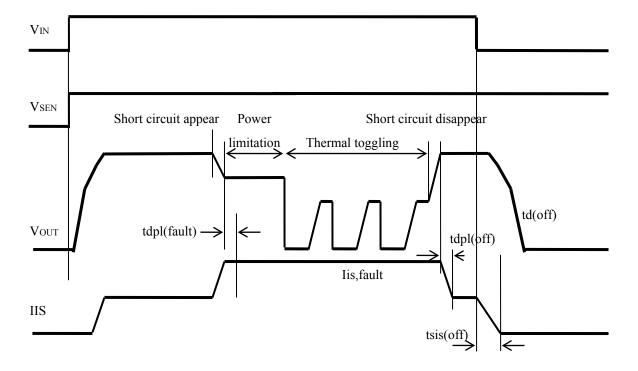
# Fault signal delay time at over current detection



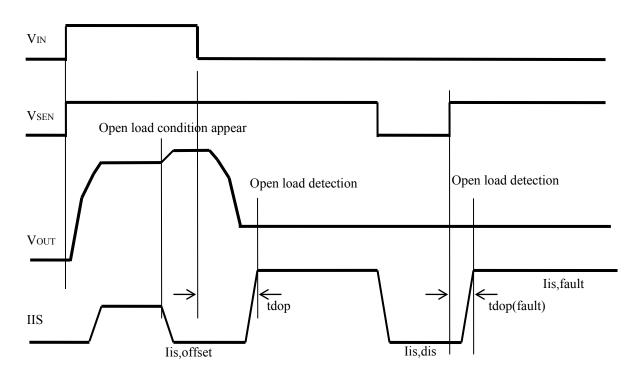
#### Fault signal delay time at power limitation



# Fault signal delay time at Thermal toggling



# Fault signal delay time at open load detection

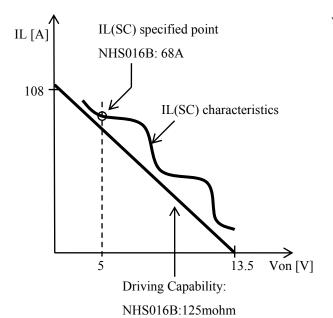


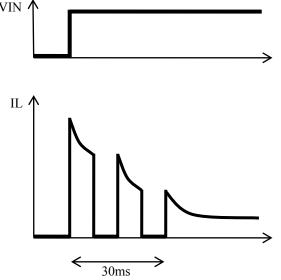
#### 3.6.8 Nominal load

Product	Nominal load
NHS016B	2.0ohm

### 3.6.9 Driving Capability

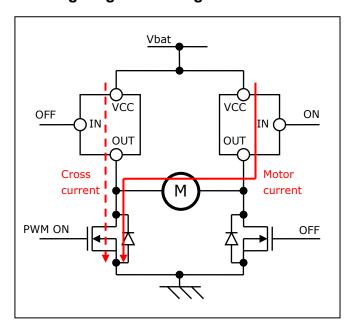
Driving Capability is specified as load impedance. Over current detection characteristics is designed below Driving Capability characteristics. If estimated load impedance which comes from peak inrush current is higher than Driving Capability characteristics, this means, the device does not detect inrush current as over current and does not shutdown the output. Depend on the conditions, Power Limitation function may work during inrush current. If estimated load impedance which comes from peak inrush current is higher than Driving Capability characteristics, Power limitation disappear within 30ms. This parameter does not mean that the device can drive the resistive load up to Driving Capability characteristics.





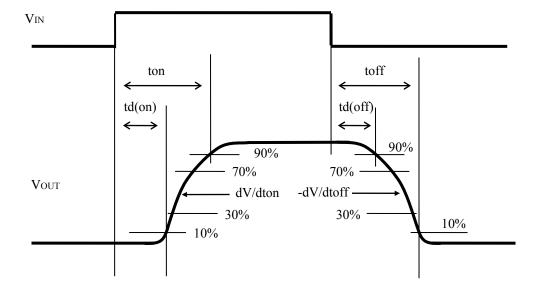
# 3.6.10 Cross current protection in case of H-bridge high side usage

In case of using High side driver in H-bridge circuit, High side driver protects High side driver itself and also low side driver from high power dissipation by cross current when low side driver switching on.



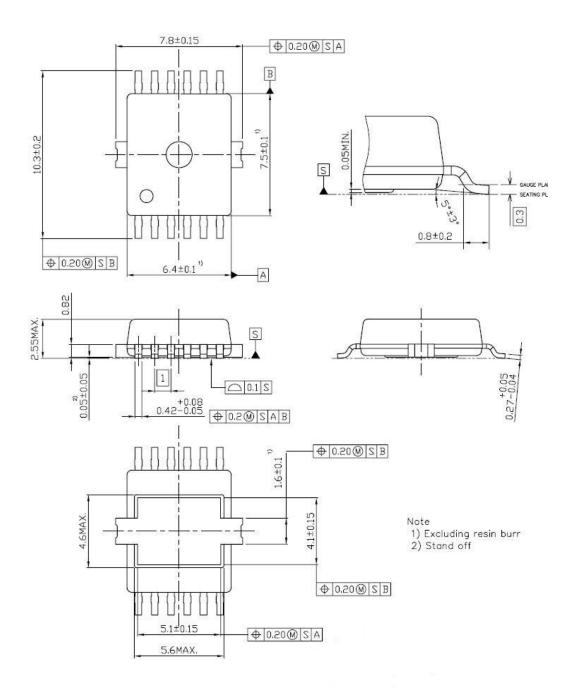
#### 3.6.11 Measurement condition

#### Switching waveform of OUT terminal



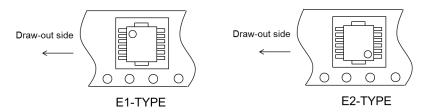
# 3.7 Package drawing

#### 12-pin Power HSSOP



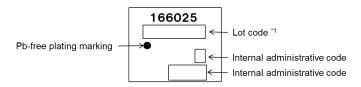
# 3.8 Taping information

uPD166025T1J

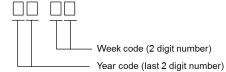


# 3.9 Marking information

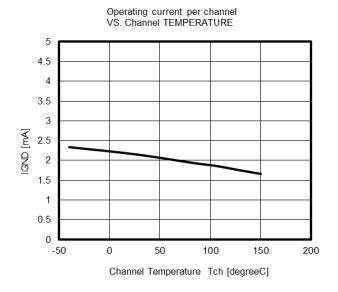
uPD166025T1J

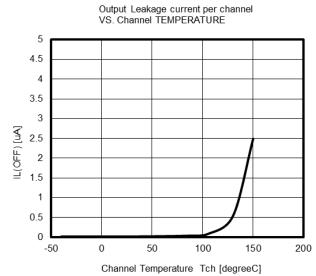


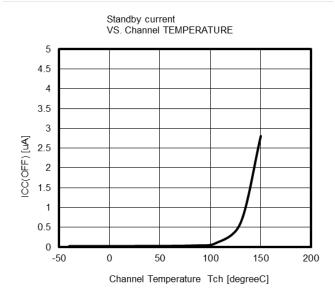
Note: \*1. Composition of the lot code

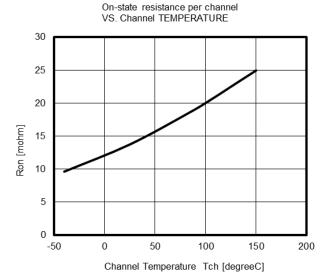


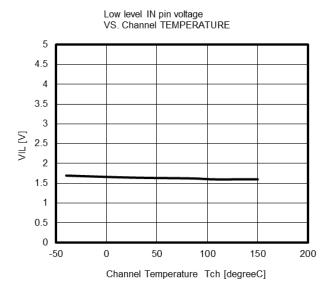
# 4. Typical characteristics

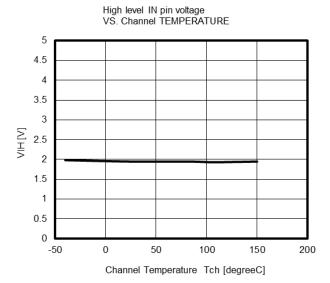


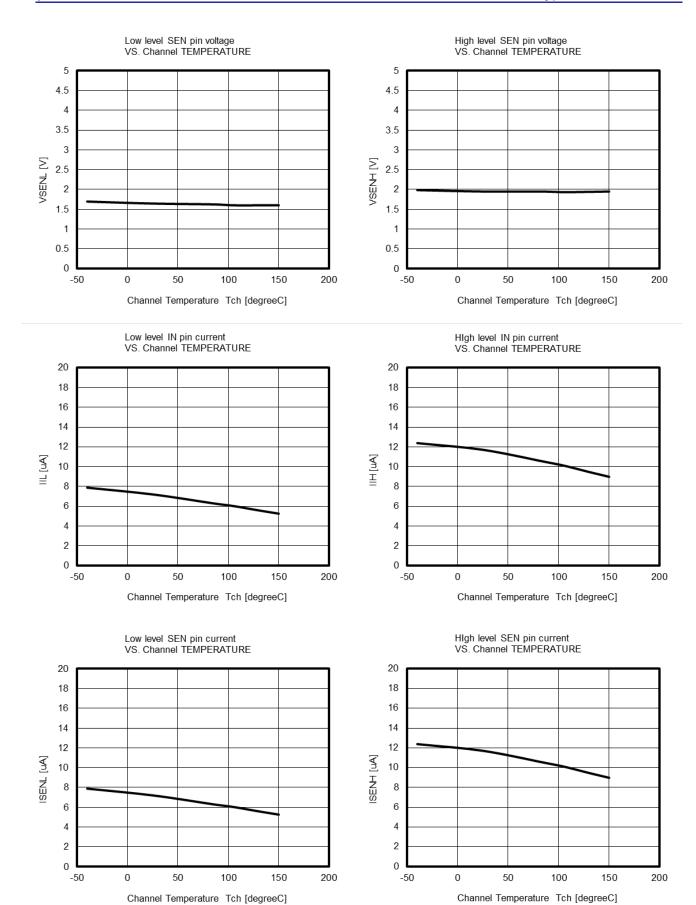


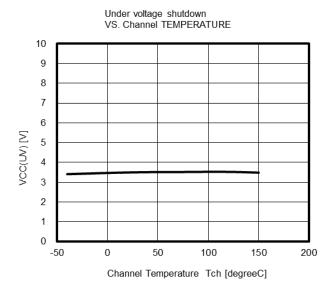


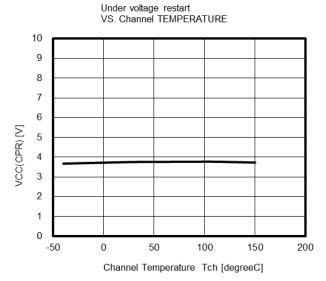


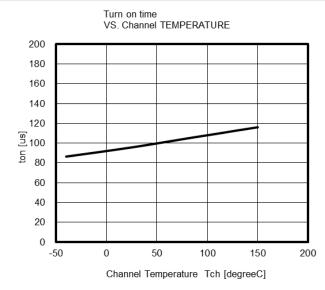


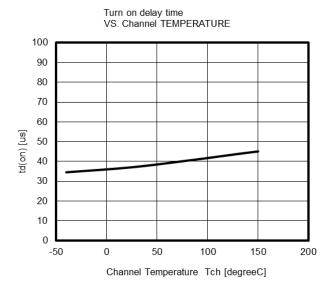


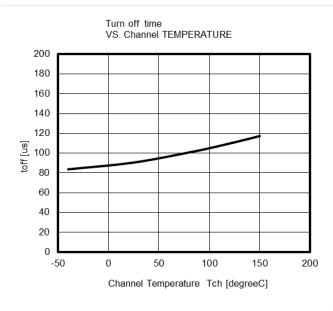


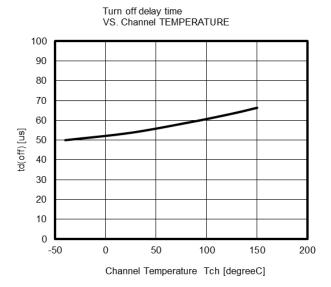


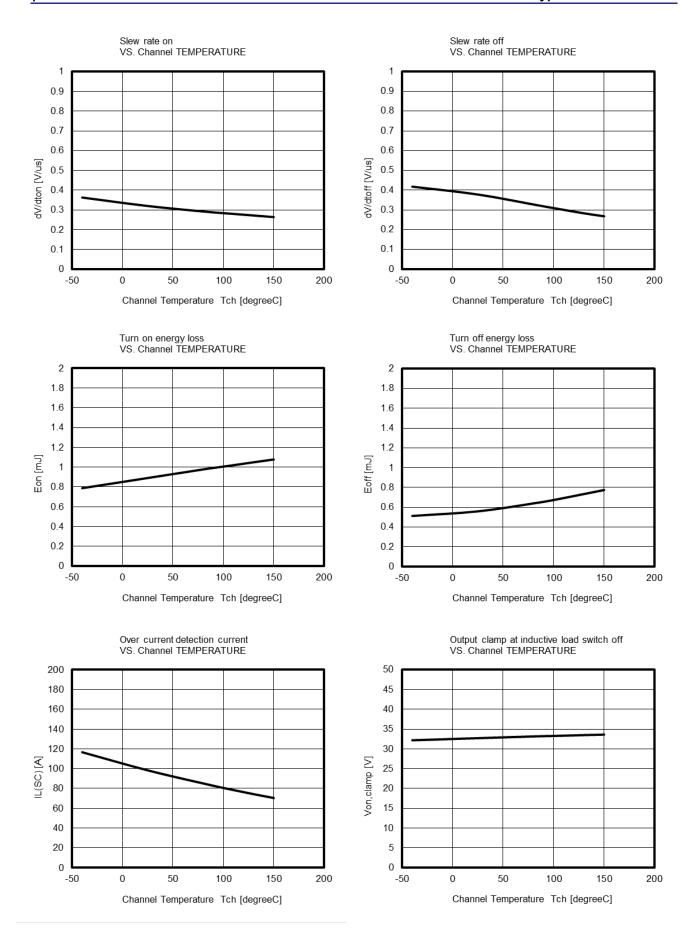


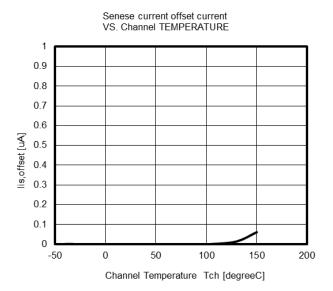


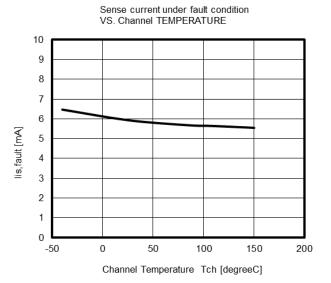




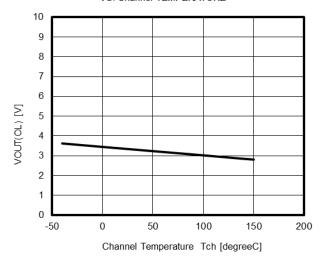




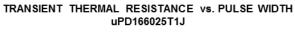


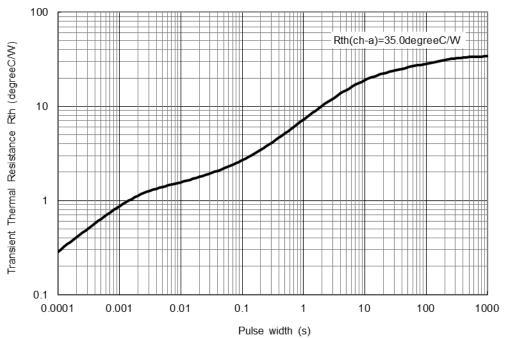


Open load detection threshold at off-state VS. Channel TEMPERATURE

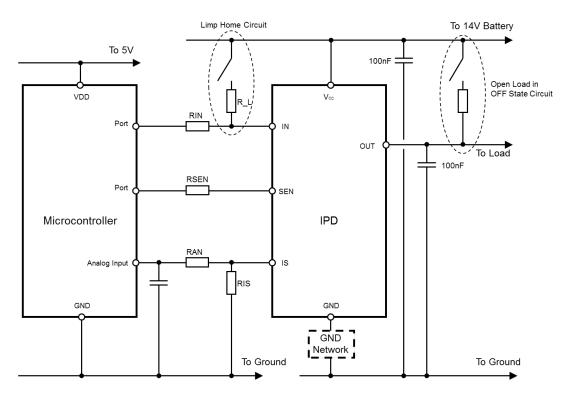


# 5. Thermal characteristics





#### 6. Application example in principle

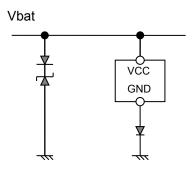


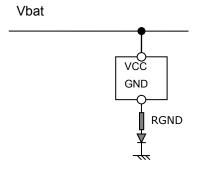
RIN, RSEN, RAN values are in range of 2k to 50kohm depending microcontroller while R\_L value is typically 4kohm. If necessary to raise HBM tolerated dose, adding resister between OUT terminal and Ground is effective. Resister's value is typically 100kohm

#### **GND Network recommendation**

In case of V\_loaddump < 35V

In case of  $35V < V_loaddump < 42V$ 





External diode is recommended in order to prevent reverse current toward control logic part at reverse battery condition.

External diode and resistor are recommended in order to prevent reverse current toward control logic part at reverse battery condition and limit the current through ZD<sub>AZ</sub> at load dump condition. 100ohm is recommended as RGND.

Note: If other component is installed to prevent reverse current at reverse battery condition, diode is not required in GND Network.

Note: Approx. 10kohm additional resistor in parallel with diode is recommended depends on Vf- If performance of the diode.

**Revision History** 

# $\mu PD166025T1J \ Datasheet$

		Description				
Rev.	Date	Page	Summary			
1.00	Sep. 17, 2013	1-38	1st issue			
2.00	May 22, 2015	23	"Device behavior at small load current conduction" is added.			

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